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IN THE CLAIMS:

A complete listing of all claims is presented below.

1. (Currently Amended) An active A CMOS pixel structure comprising:

a semiconductor substrate with dopants of a first conductivity type at a first concentration density, and with an insulating layer at its surface;

a collection region with dopants of a second conductivity type which is opposite the first conductivity type at a second concentration density, formed in the surface region of the semiconductor substrate;

a dual-purpose electrode formed on the insulating layer, extending over both the surface of at least part of the collection region and over at least part of the substrate, the dual-purpose electrode being intended to be driven by a first voltage that causes an electrostatic potential which collects in an area of the collection region beneath the dual-purpose electrode charges generated by electromagnetic radiation and by a second voltage, which is higher than the first voltage, for transferring the charges from the collection region into a detection region, and

the pixel structure being an active pixel structure having an amplifier integrated in the pixel structure and coupled to the detection region for amplifying the collected charge.

- (Previously Amended) The pixel structure recited in claim 1 wherein the substrate further comprises a barrier region of the first conductivity type with a concentration density of dopants being higher than the concentration density of dopants in the substrate.
- (Previously Amended) The pixel structure recited in claim 2 wherein said barrier region is extending at least partly under the dual-purpose electrode.
- 4. (Previously Amended) The pixel structure recited in claim 1 further comprising a detection region with dopants of the second conductivity type at a third concentration density, formed in the surface region of the semiconductor substrate and not bordering the collection region and being connected to read-out electronics.

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- 5. (Previously Amended) The pixel structure recited in claim 1, wherein the collection region forms a junction with the semiconductor substrate.
- 6. (Previously Amended) The pixel structure recited in claim 5, wherein the junction formed is a photodiode.

(Previously Amended) The pixel structure recited in claim 1, wherein the surface regions of the semiconductor substrate beyond the collection region are barrier regions which have dopants of the first conductivity type at a concentration density larger that the concentration density of the semiconductor substrate and read-out electronics are formed within shielding regions.

(Previously Amended) The pixel structure recited in claim 7, wherein at least part of the charge carriers that are generated in the semiconductor substrate underneath the shielding regions are collected by the collection region.

- 9. (Previously Amended) The pixel structure recited in claim 1, wherein a pinning region with dopants of the first conductivity type at a fourth concentration density is within the surface region.
- 10. (Previously Amended) The pixel structure recited in claim 9, wherein the pinning region is not covered by the dual-purpose electrode.
- 11. (Freviously Amended). The pixel structure recited in claim 10, wherein the pinning region is aligned with the dual-purpose electrode, and extends along the collection region.
- (Currently Amended) The pixel structure according to Claim 2, wherein the barrier region substantially impedes the diffusion of charges to said second detection region.